

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10646851	LIANG ET AL.
	<b>Examiner</b> Keefer, Michael E	<b>Art Unit</b> 2112

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	204	12/18/2006	MEK
709	202	12/19/2006	MEK
709	212	12/19/2006	MEK

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (See attached)	12/18/2006	MEK
Consulted with Examiner Charles Jae	12/20/2006	MEK
Consulted with Examiner Joshua Joo	6/12/2007	MEK
EAST Search	6/11/2007	MEK

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>